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TABULAR CUSUM CHARTS WITH STATISTICAL PROCESS CONTROL

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Keywords: CUSUM Control Chart, \overline{X} -Control Chart, Simulation, Statistical Process Control.

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Keywords: CUSUM Control Chart, X -Control Chart, Simulation, Statistical Process Control.

Introduction: The control chart is the widely applied technique for controlling the industrial processes. The pioneer work on Statistical Process Control (SPC) was done by Walter A. Shewhart in the earlier 1920's. Shewhart developed the basis for the control chart and the state of statistical control, Shewhart's charts effective for detecting large changes in process parameters; however Shewhart chart may take a longtime to detect a small persistent shift in the process parameter. The ability to detect smaller parameter Shifts can be improved by using a chart based on a statistic that corporate information from past samples in addition to current samples. One such chart is Cumulative Sum (CUSUM) control chart developed by Page (1954). This chart plots the cumulative sums of deviations of the sample values of a quality characteristic from a target value against time. It is noted that Shewhart's control chart for mean is very effective if the magnitude of the shift is 1.5 -sigma or larger (Montgomery 2001). Some authors namely Duncan (1974), Lucas (1976), Hawkins (1981), Lucas and Saccucci (1982a, 1990) stated that the

CUSUM control chart is much more efficient than the usual X control chart for detecting smaller variations in the average. There are two ways to represent a CUSUM, the tabular or algorithmic cusum and the V- mask CUSUM. Of these two forms the tabular form of the cusum is practiced more. So we consider the construction and use of the tabular CUSUM in this paper. An excellent discussion of cusum control scheme is given by Hawkins and Olwell (1998). The rest of the paper is organized as follows.

- View on the cusum control chart with principles of CUSUM control scheme.
- An example is given for Shewhart and CUSUM charts are plotted and compared.
- 3. Shift detection properties of the CUSUM are verified.
- 4. Final conclusion of the paper by a brief summary of results and discussion.

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What is a CUSUM Chart?

Like control charts, CUSUM charts are used to plot data in time-series. The charts are meant to alert users to significant changes in process performance. CUSUM charts do not plot raw data values, averages, ranges or standard deviations. Instead, plot points on a CUSUM chart are data values roughly representative of the cumulatively summed, subgroup-to-subgroup deviations from a specified target or production mean. The primary advantage of the tabular CUSUM chart is that the chart is more sensitive to small changes in the mean, especially when compared with \overline{X} and R control charts.

Cumulative Sum (CUSUM) Control Chart: CUSUM may be constructed for individual observations as well as rational subgroups. Here only case of individual observations is considered.

The Tabular CUSUM for Monitoring the Process Mean: Let x_i be the ith observation on the process. Xi has normal distribution with mean μ_0 and standard deviation σ (known or estimable), when the process is under control. Sometimes, μ_0 is taken to be the target value for the quality characteristic X. The tabular CUSUM works by accumulating the deviations from μ_0 that are above target with one statistic C+ and that are below target with another statistic C -. The statistics C+ and C - are called one sided upper and lower CUSUM respectively.

How are CUSUM Charts Created?

When compared with traditional control charts, the tabular CUSUM chart is unique, and certain parameters and statistics must be used in its creation.

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Parameter	Description
$C_{i}^{+} = max[0,x_{i} - (\mu_{0} + K_{u}) + C_{i-1}^{+}]$	The C_i^+ plot point is used exclusively for plotting the upper line on the tabular CUSUM chart. The upper line is used for identifying changes in the process above the stated target value, μ_0 .
$C_i^- = min[0, x_i - (\mu_0 - K_l) - C_{i-1}^-]$	The C_i^- point is used exclusively for plotting the lower line on the tabular CUSUM chart. The lower line is used for identifying changes in the process below the chosen target value, μ_0 .
μ ₀	Process Mean or Target value.
$\hat{\sigma}_{II} = \sqrt{\frac{\sum_{i=1}^{n} (x - \bar{x})^2}{(n-1)}}$	Sample standard deviation, or Long Term (LT) standard deviation.
msz _u	The positive shift in Process Mean that the CUSUM chart is meant to detect, in standard deviation units. Typically between 0.50 and 1.50,
mszį	The negative shift in Process Mean that the CUSUM chart is meant to detect, in standard deviation units. Typically between 0.50 and 1.50.
$K_{u} = \left(\frac{msz_{u} \times \widehat{\sigma}_{LT}}{2}\right)$	The "Upper Reference" value specified for plotted <i>Positive CUSUM</i> line. Positive CUSUM values are accumulated only when the deviation from the target value exceeds

	specified K value, K value is half the magnitude of the mean shift value to detect.			
$K_{l} = \left(\frac{msz_{l} \times \widehat{\sigma}_{LT}}{2}\right)$	The "Lower Reference" value specified for plotted Negative CUSUM line. Negative CUSUM values are accumulated only when the deviation from the target value exceeds specified K value, K value is half the magnitude of the mean shift value to detect.			
h	Decision Parameter. Factor for determining Decision Interval, II. Generally, It is defined as 5, although sometimes 4 is utilized.			
$H = h\sigma$	H is the "Decision Interval," which acts as a control limit.			
$FIR = \frac{1}{2}H$	Optional, Fast Initial Response or "head start" is typically half of H and is treated as the initial CUSUM value when no data exists.			

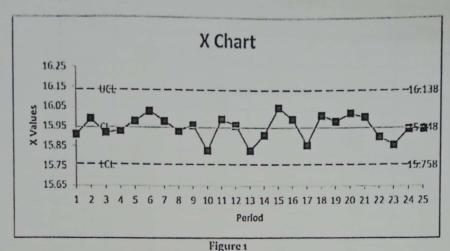
Example: A quality control inspector at the cocoa fizz soft drink company as taken 25 samples with four observations each of the volume of the bottles filled. The data and the computed means are shown in the table. If the standard deviation of bottling operation is 0.14 ounces. Using this information to develop control limits of three standard deviation for the bottle operations.

			Table 2		
Sample Number	Observations				Mean
	1	2	3	4	
1	15.85	16.02	15.83	15.93	15.91
2	16.12	16	15.85	16.01	15.99
3	16	15.91	15.94	15.83	15.92
4	16.2	15.85	15.74	15.93	15.93
5	15.74	15.86	16.21	16.1	15.98
6	15.94	16.01	16.14	16.03	16.03
7	15.75	16.21	16.01	15.86	15.98
8	15.82	15.94	16.02	15.94	15.93
9	16.04	15.98	15.83	15.98	15.96
10	15.64	15.86	15.94	15.89	15.83
11	16.11	16	16.01	15.82	15.99
12	15.72	15.85	16.12	16.15	15.96
13	15.85	15.75	15.74	15.98	15.83
14	15.73	15.84	15.96	16.1	15.91
15	16.2	16.01	16.1	15.89	16.05
16	16.12	16.08	15.83	15.94	15.99
17	16.01	15.93	15.81	15.68	15.86
18	15.78	16.04	16.11	16.12	16.01
19	15.84	15.92	16.05	16.12	
20	15.92	16.09	16.12	15.93	15.98
21	16.11	16.02	16	15.88	16.02
22	15.98	15.82	15.89	15.89	16
23	16.05	15.73	15.73		15.9
24	16.01	16.01	15.89	15.93	15.86
25	16.08	15.78		15.86	15.94
		10,70	15.92	15.98	15.94

$$\overline{X} = \frac{\sum_{i=1}^{k} \overline{X_i}}{k}$$

$$\overline{X} = \frac{\frac{192.7}{25}}{\overline{X}}$$

$$\overline{X} = \frac{15.04}{15.04}$$



Comment: All the sample observations are lies between Upper and Lower control limits, so the process is under control according to \overline{X} -Chart.

Creating the Tabular CUSUM Chart: These are several steps for creating a tabular CUSUM chart:

- 1. The data must be converted and plotted into two different CUSUM plot points:
 - a) C_l^- values indicating the cumulative summation of values below the target
 - b) b. C_i^{\dagger} values indicating the cumulative summation of values above the target
- 1. Identification of the target, μ_0
- 2. Selection of the positive shift in the mean to detect, msz_u
- 3. Selection of the negative shift in the mean to detect, msz1
- 4. Selection of Decision parameter, H

First, the CUSUM plot point values for the steel I-beam example are calculated and found Plotted Points

Following are the assumptions and calculations necessary for completing the CUSUM chart for the example:

- μ_0 = Target Value = Actual Process mean = 15.95
- $\hat{\sigma}$ = Estimated Standard Deviation = 0.0604
- 3. $msz_{u} = Positive mean shift to detect (z) = 1.00$
- $msz_1 = Negative mean shift to detect (z) = 1.00$

$$K_{\mathbf{u}} = \text{Upper Reference} = \left(\frac{msz_{\mathbf{u}} \times \widehat{\sigma}_{LT}}{2}\right) = \left(\frac{1 \times 0.0504}{2}\right) = 0.0302$$

$$K_{I = \text{Lower Reference}} = \left(\frac{msz(\times \partial_{LT})}{2}\right) = \left(\frac{1\times0.0604}{2}\right) = 0.0302$$

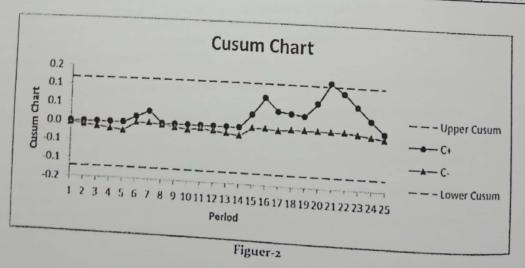
 $H = Declaton Interval = I(Q) = 9 \times Q = 9 \times 0.0604 = 0.30 \times$ the The Chich Interval = Int = 4.5 to =

 $C_t^+ = \max[0, x_t - (\mu_0 + K_n) + C_{t-1}^+]$

 $C_t^- = \min[0, x_t - (\mu_0 - K_t) - C_{t-1}^-]$

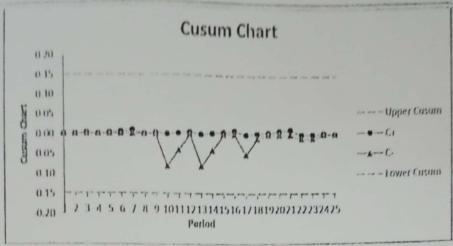
Once both the Upper and Lower CUSUM values have been calculated, they are plotted on the same

Sample	The state of the s	CONTRACTOR STREET, SAN ENGINEER, MANAGES SAN	Tabl	0.3			
Number	of the latest terms of the latest and the latest an	Observations			Mean	C_i^+	C
-	1	2	3	1			And in column 2 is not the last
Marin (Marin Control of the Control	15,85	16.02	15,83	15.93	15.91	0	-0.04
2	16.12	16	15,85	16.01	15,99	0	-0.030
-	16	15.91	15.94	15.83	15.92	0	0
4	16,2	15.85	15.74	15.93	15.93	0	-0.02
5	15.74	15.86	16.21	16.1	15.98	0	0.02
6	15.94	16.01	16.14	16.03	16.03	0.05	0
7	15.75	16.21	16.01	15.86	15.98	0.0498	0
8	15.82	15.94	16.02	15.94	15.93	0	-0.02
9	16,04	15.98	15.83	15.98	15.96	0	0.02
10	15.64	15.86	15.94	15.89	15.83	0	-
11	16.11	16	16.01	15.82	15.99	0.0098	-0.12
12	15.72	15.85	16.12	16.15	15.96	0.0058	0
13	15.85	15.75	15.74	15.98	15.83	0	0
14	15.73	15.84	15,96	16.1	15.91	0	-0.12
15	16.2	16.01	16.1	15.89	16.05	0.0698	0
16	16.12	16.08	15.83	15.94	15.99		0
17	16.01	15.93	15.81	15.68	15.86	0.0796	0
18	15.78	16.04	16.11	16.12	16.01	0	-0.09
19	15.84	15.92	16.05	16.12	15.98	0.0298	0
20	15.92	16.09	16.12	15.93		0.0296	0
21	16.11	16.02	16	15.88	16.02	0.0694	0
22	15.98	15.82	15.89	15.89	16	0.0892	0
23	16.05	15.73	15.73	15.89	15.9	0.009	-0.05
24	16.01	16.01	15.89		15.86	0	-0.04
25	16.08	15.78	15.92	15.86	15.94	0	0
			13.76	15.98	15.94	0	-0.01



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Figuer-3

Conclusion; One sided upper CUSUM Ci' verses sample number are plotted as blue color points and lower CUSUM. Ct are plotted as light blue color points. The parameter values are k=0.5 and H= 5. This control scheme (for individual observations) gives an out of control signal at 20th observation and thus ls very effective for small shifts. This control scheme gives an out of control signal for the 25 observations, indicating that the Shewhart control scheme is slow for detecting smaller shifts. Hence CUSUM control charts are more effective than Shewhart control charts,

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